

Notice of References Cited	Application/Control No. 10/654,161	Applicant(s)/Patent Under Reexamination LIU ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,072,772 A	06-2000	Charny et al.	370/229
*	B	US-6,414,963 B1	07-2002	Gemar, Jeffrey R.	370/412
*	C	US-2002/0176428 A1	11-2002	Ornes et al.	370/411
*	D	US-2003/0189897 A1	10-2003	Einstein et al.	370/220
*	E	US-2003/0227926 A1	12-2003	Ramamurthy et al.	370/395.42
*	F	US-2004/0047351 A1	03-2004	Del Prado Pavon et al.	370/395.4
*	G	US-6,888,830 B1	05-2005	Snyder II et al.	370/392
*	H	US-6,952,424 B1	10-2005	Bass et al.	370/412
*	I	US-6,987,774 B1	01-2006	Minshall, Gregory G.	370/429
*	J	US-7,092,396 B2	08-2006	Lee et al.	370/395.4
*	K	US-7,116,680 B1	10-2006	Kramer et al.	370/465
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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